

VFSTR :: VADLAMUDI

SUPPLEMENTARY SUMMATIVE ASSESSMENT NOTIFICATION

Application procedure for Supplementary Assessments scheduled in the month of January 2026.

Students can apply for the following Assessments through online from 23.12.2025 to 27.12.2025.

NAME OF THE EXAMINATIONS:

1. I B.Tech I & II Sem (R22C24) Supplementary summative Assessment Jan.-2026 (For supply 2024 batch)
2. I B.Tech I & II Sem (R22C22) Supplementary summative Assessment Jan.-2026 (For supply 2022,2023 batches)
3. I B.Tech I & II Sem (R21) Supplementary summative Assessment Jan.-2026 (For supply 2021 batch)
4. I B.Tech I & II Sem (R19) Supplementary End Examination Jan.-2026 (For supply 2019, 2020 batches)


PROCEDURE:

1. For Supplementary Registration: www.vignan.ac.in/newvignan → Academics → Assessments → Examinations → Supplementary Apply
2. Enter Register Number, select Examination Name.
3. Student can edit the mobile number displayed. Student is expected to give the mobile number to which the information related to examinations will be sent.
4. Select the subjects for supplementary.
5. The selected options will be displayed for verification. If satisfied, student can go to checkout.
6. Payment gateway opens. Student can pay as per instructions. Preferably “UPI”
7. After payment, receipt will be generated. Student can download and keep a copy for the records. There is no need for the student to send separate application.
8. Student will receive an SMS immediately confirming the successful registration. If student won't get the SMS, student can contact Exam cell 0863 – 2344700. Ext. 1092, 1093

EXAMINATION FEE: (for supplementary candidates only)

(A) For Whole Examination (All Subjects)	Rs. 2000/-
(B) For One Subject (Theory / Practical)	Rs. 500/-
(C) For Two to Four Subjects (Theory / Practical)	Rs. 1000/-
(D) For Five and above subjects (Theory / Practical)	Rs. 2000/-

**Last date to apply: 23.12.2025 to 27.12.2025 (without fine)
: 28.12.2025 to 29.12.2025 (with fine Rs.300/-)**


(Dr. P. Bangaraiah)
Controller of Examinations